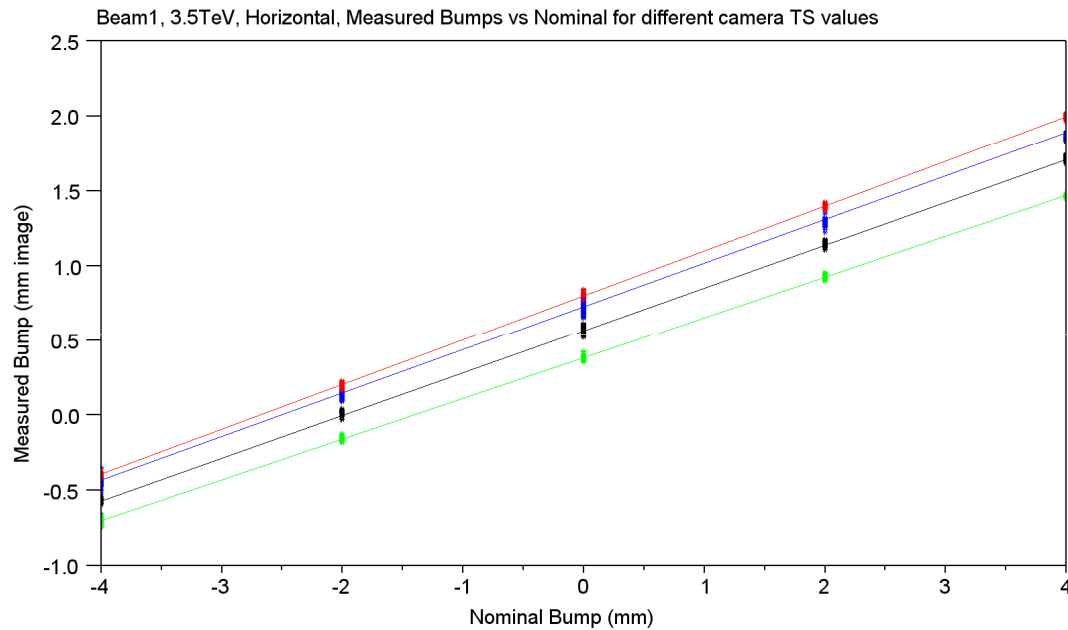
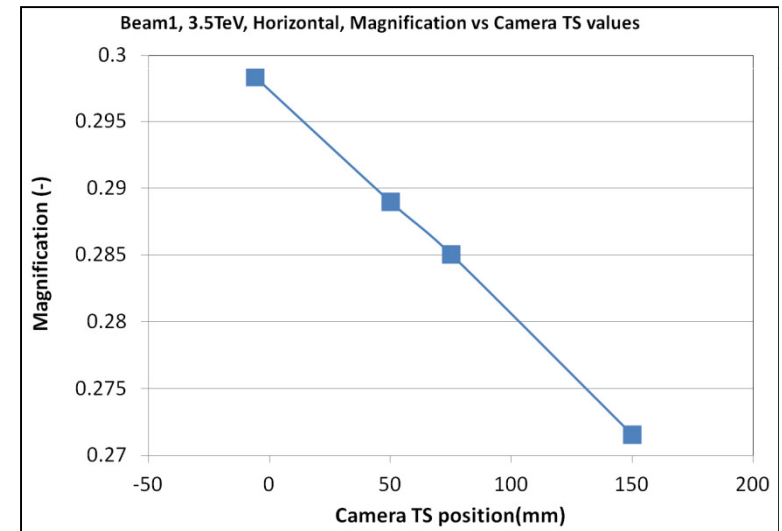
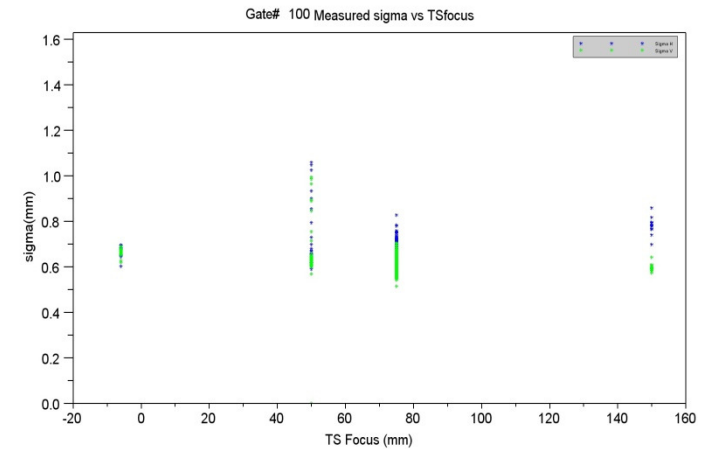


BI MD#4 05.11.2011 - BSRT Measurements

- Beam 1 and 2 @ 3.5 TeV
- 2 bunches with different emittances
- Bumps: -4, -2,0,2,4 mm



- Results: Calibration @ 3.5TeV
- Still to test:
 - influence of camera gain setting on sigma
 - Calibration B2 @ 450 GeV



BI MD#4 05.11.2011 - Matching Monitor Test

Goal was to validate the new system

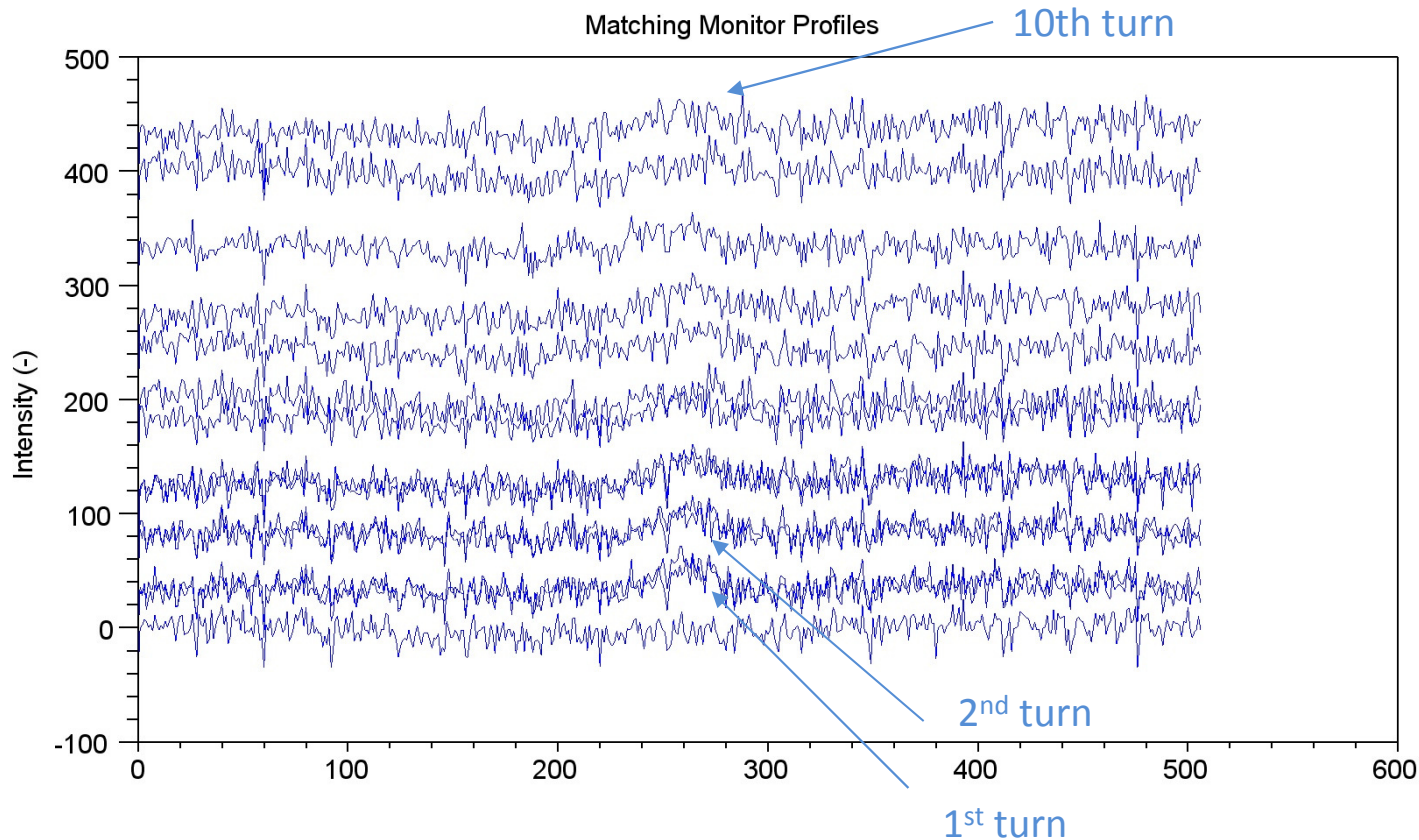
- check sensitivity of the new detector
(scan intensity 1.2 to $8e10p$)
- check timing setup
- check delay

→ 15 minutes MD instead of 1 hour

→ Beam intensity was $\sim 9e9 p$

→ No time for intensity 'scan' up to $8e10$

BI MD#4 05.11.2011 - Matching Monitor Test



Beam was seen turn/turn with $9e9$ p

Too close to the limit to use for measurements

- Better signal with new optics (achromatic lenses – gain to be measured)
- With Present design, measurements could be done by increasing a bit the intensity
- Need commissioning time for timing and delay tests

BPMWA.A5L4.B1 scan (Nov 5, 2011)

Target: to scan a BPM to estimate the non-linearity error of existing orbit correction

Measurement: bump-map 21 points within $[-4,4] \times [-4,4]$ mm area (1mm/2mm bumps).

Initially we planned to scan the BPMS and with higher offsets, but due to time constraints we could only use BPMWA. However, this should suffice to show the difference and significance of using cross-term polynomials for accurate position correction.

Verification: the results are compatible with the model, we see similar errors at 4 mm offsets.

Mapping of BPMS/SW with larger beam offsets is desired for next BI MD.

